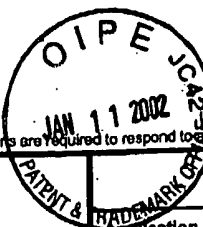


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Filing Date	July 13, 2001
First Named Inventor	Lynn E. VANATTA
Group Art Unit	To Be Assigned
Examiner Name	To Be Assigned
Attorney Docket Number	25185-P001US

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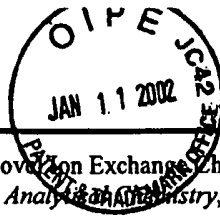
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